

# KA78MXX

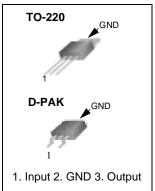
# 3-Terminal 0.5A Positive Voltage Regulator

#### **Features**

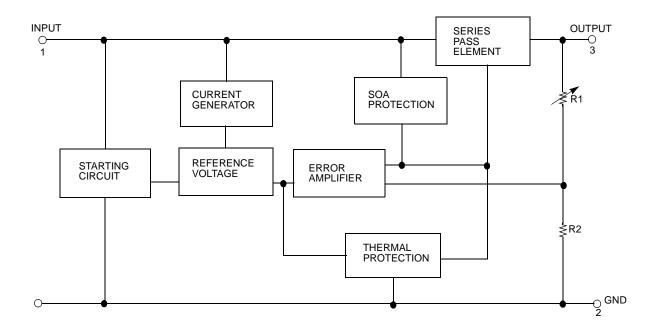
- Output Current up to 0.5A
- Output Voltages of 5, 6, 8, 12, 15, 18, 24V
- Thermal Overload Protection
- Short Circuit Protection
- Output Transistor Safe Operating Area (SOA) Protection

### **Description**

The KA78MXX series of three terminal positive regulators are available in the TO-220/D-PAK package with several fixed output voltages making it useful in a wide range of applications.



### **Internal Block Diagram**



# **Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Input Voltage (for V <sub>O</sub> = 5V to 18V) (for V <sub>O</sub> = 24V)	VI VI	35 40	V V
Thermal Resistance Junction-Cases (Note1) TO-220 (Tc = +25°C)	R <sub>θ</sub> JC	2.5	°C/W
Thermal Resistance Junction-Air (Note1,2) TO-220 (Ta = +25°C) D-PAK (Ta = +25°C)	R <sub>θ</sub> JA	66 92	°C/W
Operating Junction Temperature Range	TOPR	0 ~ +150	°C
Storage Temperature Range	TSTG	-65 ~ +150	°C

#### Note:

- Thermal resistance test board Size: 76.2mm \* 114.3mm \* 1.6mm(1S0P) JEDEC standard: JESD51-3, JESD51-7
- 2. Assume no ambient airflow

### **Electrical Characteristics (KA78M05/KA78M05R)**

(Refer to the test circuits,  $0 \le T_J \le +125^{\circ}C$ ,  $I_O=350mA$ ,  $V_I=10V$ , unless otherwise specified,  $C_I=0.33\mu F$ ,  $C_O=0.1\mu F$ )

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit	
		TJ =+25°C		4.8	5	5.2		
Output Voltage	Vo	I <sub>O</sub> = 5 to 350mA V <sub>I</sub> = 7 to 20V	•		5	5.25	V	
Line Regulation (Note3)	ΔVο	IO = 200mA	V <sub>I</sub> = 7 to 25V	-	-	100	mV	
Line Regulation (Notes)	ΔνΟ	$TJ = +25^{\circ}C$ $V_I$	V <sub>I</sub> = 8 to 25V	-	-	50	IIIV	
Load Regulation (Note3)	ΔVο	$I_0 = 5 \text{mA to } 0.5 A$	Λ, TJ = +25°C	-	-	100	mV	
Load Regulation (Notes)	ΔνΟ	IO = 5mA to 200	mA, TJ =+25°C	-	-	50	IIIV	
Quiescent Current	IQ	T <sub>J</sub> = +25°C		-	4.0	6.0	mA	
		IO = 5mA to 350mA		IO = 5mA to 350mA		-	0.5	
Quiescent Current Change	ΔlQ	I <sub>O</sub> = 200mA V <sub>I</sub> = 8 to 25V		-	-	0.8	mA	
Output Voltage Drift	ΔV/ΔΤ	I <sub>O</sub> = 5mA T <sub>J</sub> = 0 to +125°C		-	-0.5	-	mV/°C	
Output Noise Voltage	VN	f = 10Hz to 100k	Hz	-	40	-	μV/Vo	
Ripple Rejection	RR	f = 120Hz, IO = 300mA VI = 8 to 18V, TJ = +25°C		-	80	-	dB	
Dropout Voltage	VD	T <sub>J</sub> = +25°C, I <sub>O</sub> = 500mA		-	2	-	V	
Short Circuit Current	Isc	T <sub>J</sub> = +25°C, V <sub>I</sub> = 35V		-	300	-	mA	
Peak Current	IPK	TJ = +25°C		-	700	-	mA	

<sup>3.</sup> Load and line regulation are specified at constant junction temperature. Change in V<sub>0</sub> due to heating effects must be taken into account separately. Pulse testing with low duty is used.

# Electrical Characteristics (KA78M06/KA78M06R) (Continued)

(Refer to the test circuits,  $0 \le TJ \le +125$ °C, IO=350mA, VI=11V, unless otherwise specified, CI =0.33 $\mu$ F, CO=0.1 $\mu$ F)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit		
		T <sub>J</sub> = +25°C		T <sub>J</sub> = +25°C		5.75	6	6.25	
Output Voltage	Vo	IO = 5 to 350m V <sub>I</sub> = 8 to 21V	IO = 5 to 350mA V <sub>I</sub> = 8 to 21V		6	6.3	V		
Line Regulation (Note1)	ΔVο	Io = 200mA	VI = 8 to 25V	-	-	100	mV		
Line Regulation (Note I)	ΔνΟ	TJ =+25°C	V <sub>I</sub> = 9 to 25V	-	-	50	1111		
Load Population (Note1)	ΔVο	IO = 5mA  to  0.5	5A, TJ =+25°C	-	-	120	mV		
Load Regulation (Note1)	ΔνΟ	I <sub>O</sub> = 5mA to 200mA, T <sub>J</sub> =+25°C -	-	-	60	IIIV			
Quiescent Current	IQ	T <sub>J</sub> =+25°C		-	4.0	6.0	mA		
	ΔlQ	I <sub>O</sub> = 5mA to 350mA I <sub>O</sub> = 200mA V <sub>I</sub> = 9 to 25V		-	-	0.5			
Quiescent Current Change				-	-	0.8	mA		
Output Voltage Drift	ΔV/ΔΤ	IO = 5mA T <sub>J</sub> = 0 to +125°C		-	-0.5	-	mV/°C		
Output Noise Voltage	VN	f = 10Hz to 100	)kHz	-	45	-	μV/Vo		
Ripple Rejection	RR	f = 120Hz, I <sub>O</sub> = 300mA V <sub>I</sub> = 9 to 19V, T <sub>J</sub> = +25°C		-	80	-	dB		
Dropout Voltage	VD	T <sub>J</sub> =+25°C, I <sub>O</sub> = 500mA		-	2	-	V		
Short Circuit Current	Isc	TJ= +25°C, VI = 35V		-	300	-	mA		
Peak Current	IPK	TJ =+25°C		-	700	-	mA		

<sup>1.</sup> Load and line regulation are specified at constant, junction temperature. Change in  $V_0$  due to heating effects must be taken into account separately. Pulse testing with low duty is used.

# Electrical Characteristics (KA78M08/KA78M08R) (Continued)

(Refer to the test circuits,  $0 \le TJ \le +125$ °C, IO=350mA, VI=14V, unless otherwise specified, CI =0.33 $\mu$ F, CO=0.1 $\mu$ F)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit
		$T_J = +25^{\circ}C$		7.7	8	8.3	
Output Voltage	Vo	IO = 5 to 350mA V <sub>I</sub> = 10.5 to 23V		7.6	8	8.4	V
Line Regulation (Note1)	ΔVο	IO = 200mA	V <sub>I</sub> = 10.5 to 25V	-	-	100	mV
Line Regulation (Note I)	ΔνΟ	TJ =+25°C	V <sub>I</sub> = 11 to 25V	-	-	50	1117
Load Population (Note1)	ΔVο	IO = 5mA to 0.5	A, TJ = +25°C	-	-	160	mV
Load Regulation (Note1)	ΔνΟ	Io = 5mA to 200	mA, T <sub>J</sub> = +25°C	-	-	80	mv
Quiescent Current	IQ	TJ = +25°C		-	4.0	6.0	mA
		IO = 5mA to 350mA		-	-	0.5	
Quiescent Current Change	ΔlQ	I <sub>O</sub> = 200mA V <sub>I</sub> = 10.5 to 25V		-	-	0.8	mA
Output Voltage Drift	RR	IO = 5mA T <sub>J</sub> = 0 to +125°C		-	-0.5	-	mV/°C
Output Noise Voltage	VN	f = 10Hz to 100k	(Hz	-	52	-	μV/Vo
Ripple Rejection	RR	f = 120Hz, I <sub>O</sub> = 300mA V <sub>I</sub> = 11.5 to 21.5V, T <sub>J</sub> = +25°C		-	80	-	dB
Dropout Voltage	VD	T <sub>J</sub> =+25°C, I <sub>O</sub> = 500mA		-	2	-	V
Short Circuit Current	Isc	T <sub>J</sub> =+25°C, V <sub>I</sub> = 35V		-	300	-	mA
Peak Current	IPK	TJ =+25°C		-	700	-	mA

<sup>1.</sup> Load and line regulation are specified at constant, junction temperature. Change in  $V_0$  due to heating effects must be taken into account separately. Pulse testing with low duty is used.

# Electrical Characteristics (KA78M12/KA78M12R) (Continued)

(Refer to the test circuits,  $0 \le TJ \le +125$ °C, IO=350mA, VI=19V, unless otherwise specified, CI =0.33 $\mu$ F, CO=0.1 $\mu$ F)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit		
		T <sub>J</sub> = +25°C		T <sub>J</sub> = +25°C		11.5	12	12.5	
Output Voltage	Vo	IO = 5 to 350mA V <sub>I</sub> = 14.5 to 27V		11.4	12	12.6	V		
Line Regulation (Note1)	ΔVο	IO = 200mA	V <sub>I</sub> = 14.5 to 30V	-	-	100	mV		
Line Regulation (Note1)	ΔνΟ	T <sub>J</sub> = +25°C	V <sub>I</sub> = 16 to 30V	-	-	50	IIIV		
Load Population (Note1)	ΔVο	IO = 5mA  to  0.5a	A, TJ = +25°C	-	-	240	mV		
Load Regulation (Note1)	ΔνΟ	I <sub>O</sub> = 5mA to 200	mA, TJ =+25°C	-	-	120 mv	IIIV		
Quiescent Current	IQ	TJ=+25°C		-	4.1	6.0	mA		
		I <sub>O</sub> = 5mA to 350mA		-	-	0.5			
Quiescent Current Change	ΔlQ	I <sub>O</sub> = 200mA V <sub>I</sub> = 14.5 to 30V		-	-	0.8	mA		
Output Voltage Drift	ΔV/ΔΤ	IO = 5mA T <sub>J</sub> = 0 to +125°C		-	-0.5	-	mV/°C		
Output Noise Voltage	VN	f = 10Hz to 100k	(Hz	-	75	-	μV/Vo		
Ripple Rejection	RR	f = 120Hz, I <sub>O</sub> = 300mA V <sub>I</sub> = 15 to 25V, T <sub>J</sub> = +25°C		-	80	-	dB		
Dropout Voltage	VD	T <sub>J</sub> =+25°C, I <sub>O</sub> = 500mA		-	2	-	V		
Short Circuit Current	Isc	TJ= +25°C, VI = 35V		-	300	-	mA		
Peak Current	IPK	T <sub>J</sub> = +25°C		-	700	-	mA		

<sup>1.</sup> Load and line regulation are specified at constant, junction temperature. Change in  $V_0$  due to heating effects must be taken into account separately. Pulse testing with low duty is used.

# Electrical Characteristics (KA78M15) (Continued)

(Refer to the test circuits,  $0 \le T_J \le +125^{\circ}C$ , IO=350mA, VI=23V, unless otherwise specified, CI =0.33 $\mu$ F, CO=0.1 $\mu$ F)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit		
		T <sub>J</sub> =+25°C		T <sub>J</sub> =+25°C		14.4	15	15.6	
Output Voltage	Vo	IO = 5 to 350m V <sub>I</sub> = 17.5 to 30		14.25	15	15.75	V		
Line Regulation (Note1)	ΔVο	Io = 200mA	VI = 17.5 to 30V	-	-	100	mV		
Line Regulation (Note I)	ΔνΟ	$T_J = +25^{\circ}C$	V <sub>I</sub> = 20 to 30V	-	-	50	IIIV		
Load Population (Note1)	ΔVο	IO = 5mA  to  0.	5A, TJ =+25°C	-	-	300	mV		
Load Regulation (Note1)	ΔνΟ	I <sub>O</sub> = 5mA to 20	00mA, T <sub>J</sub> =+25°C	-	-	150	IIIV		
Quiescent Current	IQ	TJ =+25°C		-	4.1	6.0	mA		
		IO = 5mA to 350mA		-	-	0.5			
Quiescent Current Change	ΔlQ	I <sub>O</sub> = 200mA V <sub>I</sub> = 17.5 to 30V		-	-	0.8	mA		
Output Voltage Drift	ΔV/ΔΤ	IO = 5mA T <sub>J</sub> = 0 to +125°C		-	-1	-	mV/°C		
Output Noise Voltage	VN	f = 10Hz to 100	OkHz	-	100	-	μV/Vo		
Ripple Rejection	RR	f = 120Hz, I <sub>O</sub> = 300mA V <sub>I</sub> = 18.5 to 28.5V, T <sub>J</sub> = +25°C		-	70	-	dB		
Dropout Voltage	VD	T <sub>J</sub> =+25°C, I <sub>O</sub> = 500mA		-	2	-	V		
Short Circuit Current	Isc	TJ= +25°C, VI = 35V		-	300	-	mA		
Peak Current	IPK	T <sub>J</sub> = +25°C		-	700	ı	mA		

<sup>1.</sup> Load and line regulation are specified at constant, junction temperature. Change in  $V_0$  due to heating effects must be taken into account separately. Pulse testing with low duty is used.

# Electrical Characteristics (KA78M18) (Continued)

(Refer to the test circuits,  $0 \le TJ \le +125$ °C, IO=350mA, VI=26V, unless otherwise specified, CI =0.33 $\mu$ F, CO=0.1 $\mu$ F)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit		
		T <sub>J</sub> = +25°C		17.3	18	18.7			
Output Voltage	Vo	_	I <sub>O</sub> = 5 to 350mA V <sub>I</sub> = 20.5 to 33V		18	18.9	18.9 V		
Line Regulation (Note1)	4\/0	Io = 200mA	V <sub>I</sub> = 21 to 33V	-	-	100	mV		
Line Regulation (Note I)	ΔVΟ	T <sub>J</sub> =+25°C	V <sub>I</sub> = 24 to 33V	-	-	50	IIIV		
Load Population (Note1)	ΔVΟ	IO = 5mA to 0.5	A, TJ = +25°C	-	-	360	mV		
Load Regulation (Note1)	ΔνΟ	I <sub>O</sub> = 5mA to 200	IO = 5mA to 200mA, T <sub>J</sub> = +25°C		-	180	IIIV		
Quiescent Current	IQ	TJ =+25°C		-	4.2	6.0	mA		
		IO = 5mA to 350mA		IO = 5mA to 350mA		-	-	0.5	
Quiescent Current Change	ΔlQ	I <sub>O</sub> = 200mA V <sub>I</sub> = 21 to 33V	9		-	0.8	mA		
Output Voltage Drift	ΔV/ΔΤ	IO = 5mATJ = 0	to 125°C	-	-1.1	-	mV/°C		
Output Noise Voltage	VN	f = 10Hz to 100	kHz	-	100	-	μV/Vo		
Ripple Rejection	RR	f = 120Hz, I <sub>O</sub> =300mA , V <sub>I</sub> =22 to 32V T <sub>J</sub> = +25°C		-	70	-	dB		
Dropout Voltage	VD	TJ = +25°C, IO=500mA		-	2	-	V		
Short Circuit Current	Isc	T <sub>J</sub> = +25°C, V <sub>I</sub> =35V		-	300	-	mA		
Peak Current	IPK	T <sub>J</sub> = +25°C		-	700	-	mA		

<sup>1.</sup> Load and line regulation are specified at constant, junction temperature. Change in  $V_0$  due to heating effects must be taken into account separately. Pulse testing with low duty is used.

# Electrical Characteristics (KA78M24) (Continued)

(Refer to the test circuits,  $0 \le TJ \le +125$ °C, IO=350mA, VI=33V, unless otherwise specified, CI =0.33 $\mu$ F, CO=0.1 $\mu$ F)

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit		
		T <sub>J</sub> = +25°C		T <sub>J</sub> = +25°C		23	24	25	
Output Voltage	Vo	IO = 5 to 350n V <sub>I</sub> = 27 to 38V		22.8	24	25.2	V		
Line Regulation	ΔVο	Io = 200mA	VI = 27 to 38V	-	-	100	mV		
Line Regulation	ΔνΟ	T <sub>J</sub> = +25°C	V <sub>I</sub> = 28 to 38V	-	-	50	IIIV		
Load Population	41/0	IO = 5mA to 0	.5A, TJ =+25°C	-	-	480	mV		
Load Regulation	ΔVο	I <sub>O</sub> = 5mA to 2	00mA, TJ =+25°C	-	-	240	IIIV		
Quiescent Current	IQ	TJ = +25°C		-	4.2	6	mA		
		I <sub>O</sub> = 5mA to 350mA		-	-	0.5			
Quiescent Current Change	ΔlQ	I <sub>O</sub> = 200mA V <sub>I</sub> = 27 to 38V		-	-	0.8	mA		
Output Voltage Drift	ΔV/ΔΤ	IO = 5mA T <sub>J</sub> = 0 to +125°C		-	-1.2	-	mV/°C		
Output Noise Voltage	VN	f = 10Hz to 10	0kHz	-	170	-	μV		
Ripple Rejection	RR	f = 120Hz, I <sub>O</sub> = 300mA V <sub>I</sub> = 28 to 38V, T <sub>J</sub> = +25°C		-	70	-	dB		
Dropout Voltage	VD	T <sub>J</sub> =+25°C, I <sub>O</sub> = 500mA		-	2	-	V		
Short Circuit Current	Isc	T <sub>J</sub> = +25 °C, V <sub>I</sub> = 35V		-	300	-	mA		
Peak Current	IPK	T <sub>J</sub> = +25°C		-	700	-	mA		

<sup>1.</sup> Load and line regulation are specified at constant, junction temperature. Change in  $V_0$  due to heating effects must be taken into account separately. Pulse testing with low duty is used.

# **Typical Applications**

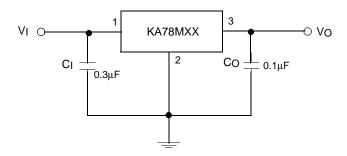


Figure 1. Fixed Output Regulator

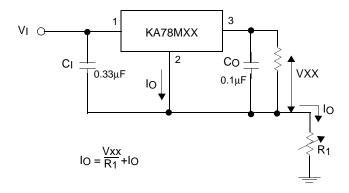


Figure 2. Constant Current Regulator

- 1. To specify an output voltage, substitute voltage value for "XX"
- 2. Although no output capacitor is needed for stability, it does improve transient response.
- 3. Required if regulator is located an appreciable distance from power Supply filter

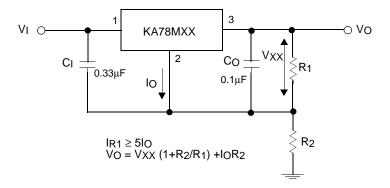


Figure 3. Circuit for Increasing Output Voltage

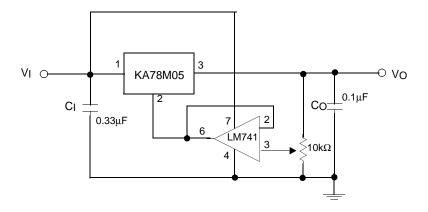


Figure 4. Adjustable Output Regulator (7 to 30V)

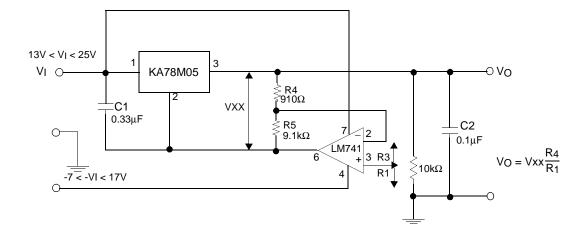


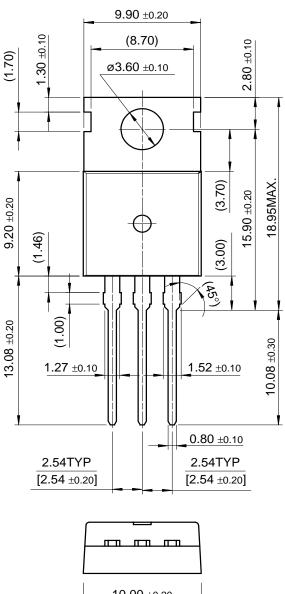
Figure 5. 0.5 to 10V Regulator

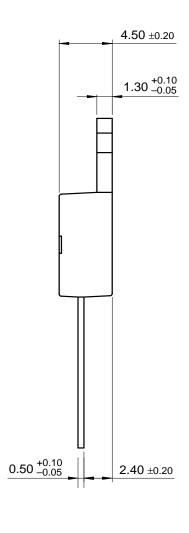
### **Mechanical Dimensions**

### **Package**

### **Dimensions in millimeters**

**TO-220** 

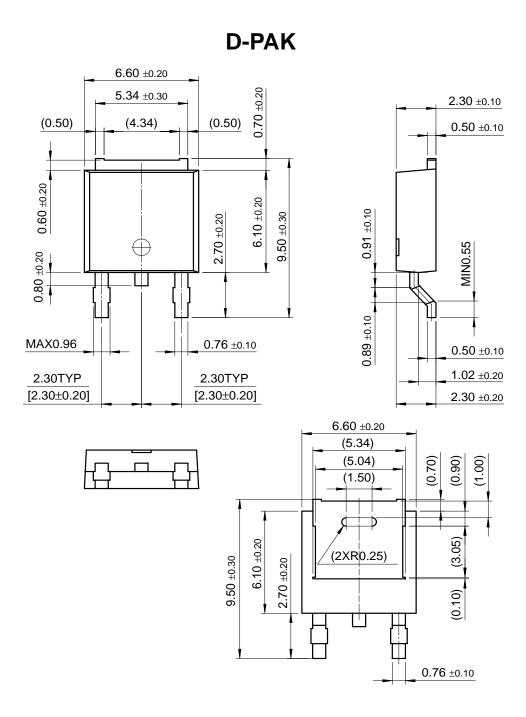




### **Mechanical Dimensions** (Continued)

### **Package**

### **Dimensions in millimeters**



# **Ordering Information**

Product Number	Package	Operating Temperature			
KA78M05					
KA78M06					
KA78M08	TO-220 0 ~ +125°C				
KA78M12					
KA78M15					
KA78M18		0 ~ +125°C			
KA78M24					
KA78M05R					
KA78M06R	D-PAK				
KA78M08R					
KA78M12R	]				

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